

<b>Notice of References Cited</b>	Application/Control No. 10/708,830	Applicant(s)/Patent Under Reexamination BEENAU ET AL.	
	Examiner Karl D. Frech	Art Unit 2876	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0083320	06-2002	Vatanen, Harri	713/168
	B	US-2003/0093187	05-2003	Walker, Richard C.	701/1
	C	US-2001/0013546	08-2001	Ross, William Leslie	235/382
	D	US-6,588,660	07-2003	Buescher et al.	235/382
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
✓	N	9606409A1	02-1996	WO	GeeField	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.